

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/811,316	PACK ET AL.	
				Examiner	Art Unit	
				SANG KIM	3654	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
242	418	6/9/2006	SK	John Nguyen: 242/418, 420, 557, 563, 564, 564.4	6/8/2006	SK
242	420	6/9/2006	SK			
242	557	6/9/2006	SK			
242	563	6/9/2006	SK			
242	564	6/9/2006	SK			
242	564.4	6/9/2006	SK			
191	12.2A	6/9/2006	SK			
191	12.2R	6/9/2006	SK			
901	1	6/9/2006	SK			
89	1.13	6/9/2006	SK			
<i>updated above</i>	<i>SK</i>	<i>7-26-07</i>	<i>SK</i>			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			